

International **IR** Rectifier

HEXFET® POWER MOSFET SURFACE MOUNT (SMD-0.5)

PD - 94020A

**IRF5NJ540
100V, N-CHANNEL**

Product Summary

| Part Number | BVDSS | RDS(on) | ID |
|-------------|-------|---------|------|
| IRF5NJ540 | 100V | 0.052Ω | 22A* |

Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon unit area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

These devices are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high-energy pulse circuits.



SMD-0.5

Features:

- Low RDS(on)
- Avalanche Energy Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Parallelizing
- Hermetically Sealed
- Surface Mount
- Light Weight

Absolute Maximum Ratings

| Parameter | Units | |
|----------------------------|-------|--------------------------------------|
| ID @ VGS = 10V, TC = 25°C | A | Continuous Drain Current |
| ID @ VGS = 10V, TC = 100°C | | 16 |
| IDM | W | Pulsed Drain Current ① |
| PD @ TC = 25°C | W | Max. Power Dissipation |
| | W/C | Linear Derating Factor |
| VGS | V | Gate-to-Source Voltage |
| EAS | mJ | Single Pulse Avalanche Energy ② |
| IAR | A | Avalanche Current ① |
| EAR | mJ | Repetitive Avalanche Energy ① |
| dv/dt | V/ns | Peak Diode Recovery dv/dt ③ |
| TJ | °C | Operating Junction |
| TSTG | | Storage Temperature Range |
| | | Package Mounting Surface Temperature |
| | g | Weight |

* Current is limited by package

For footnotes refer to the last page

www.irf.com

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7/13/01

Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (Unless Otherwise Specified)

| | Parameter | Min | Typ | Max | Units | Test Conditions |
|---------------------------|--|-----|------|-------|---------------------|---|
| BVDSS | Drain-to-Source Breakdown Voltage | 100 | — | — | V | $V_{GS} = 0V, I_D = 250\mu\text{A}$ |
| $\Delta BVDSS/\Delta T_J$ | Temperature Coefficient of Breakdown Voltage | — | 0.11 | — | V/ $^\circ\text{C}$ | Reference to 25°C , $I_D = 1.0\text{mA}$ |
| RDS(on) | Static Drain-to-Source On-State Resistance | — | — | 0.052 | Ω | $V_{GS} = 10V, I_D = 16A$ ④ |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | 2.0 | — | 4.0 | V | $V_{DS} = V_{GS}, I_D = 250\mu\text{A}$ |
| g_{fs} | Forward Transconductance | 11 | — | — | S (d) | $V_{DS} = 50V, I_{DS} = 16A$ ④ |
| I_{DSS} | Zero Gate Voltage Drain Current | — | — | 25 | μA | $V_{DS} = 100V, V_{GS}=0V$ |
| | | — | — | 250 | | $V_{DS} = 80V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Leakage Forward | — | — | 100 | nA | $V_{GS} = 20V$ |
| I_{GSS} | Gate-to-Source Leakage Reverse | — | — | -100 | | $V_{GS} = -20V$ |
| Q_g | Total Gate Charge | — | — | 104 | nC | $V_{GS} = 10V, I_D = 16A$ |
| Q_{gs} | Gate-to-Source Charge | — | — | 20 | | $V_{DS} = 80V$ |
| Q_{gd} | Gate-to-Drain ('Miller') Charge | — | — | 43 | | |
| $t_{d(on)}$ | Turn-On Delay Time | — | — | 24 | ns | $V_{DD} = 50V, I_D = 16A, V_{GS} = 10V, R_G = 7.5\Omega$ |
| t_r | Rise Time | — | — | 125 | | |
| $t_{d(off)}$ | Turn-Off Delay Time | — | — | 86 | | |
| t_f | Fall Time | — | — | 82 | | |
| $L_S + L_D$ | Total Inductance | — | 4.0 | — | nH | Measured from the center of drain pad to center of source pad |
| C_{iss} | Input Capacitance | — | 1487 | — | pF | $V_{GS} = 0V, V_{DS} = 25V, f = 1.0\text{MHz}$ |
| C_{oss} | Output Capacitance | — | 353 | — | | |
| C_{rss} | Reverse Transfer Capacitance | — | 182 | — | | |

Source-Drain Diode Ratings and Characteristics

| | Parameter | Min | Typ | Max | Units | Test Conditions |
|----------|--|--|-----|------|---------------|--|
| I_S | Continuous Source Current (Body Diode) | — | — | 22* | A | $T_j = 25^\circ\text{C}, I_S = 16A, V_{GS} = 0V$ ④ |
| I_{SM} | Pulse Source Current (Body Diode) ① | — | — | 88 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.3 | V | |
| t_{rr} | Reverse Recovery Time | — | — | 240 | nS | $T_j = 25^\circ\text{C}, I_F = 16A, di/dt \leq 100A/\mu\text{s}$ |
| QRR | Reverse Recovery Charge | — | — | 1.67 | μC | $V_{DD} \leq 50V$ ④ |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$. | | | | |

* Current is limited by package

Thermal Resistance

| | Parameter | Min | Typ | Max | Units | Test Conditions |
|------------|------------------|-----|-----|------|--------------------|-----------------|
| R_{thJC} | Junction-to-Case | — | — | 1.67 | $^\circ\text{C/W}$ | |

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

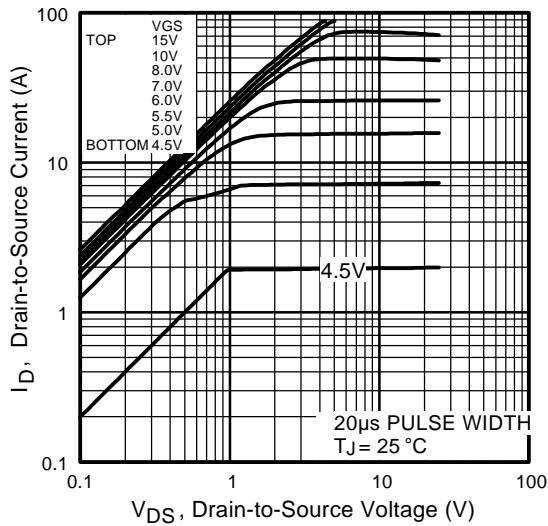


Fig 1. Typical Output Characteristics

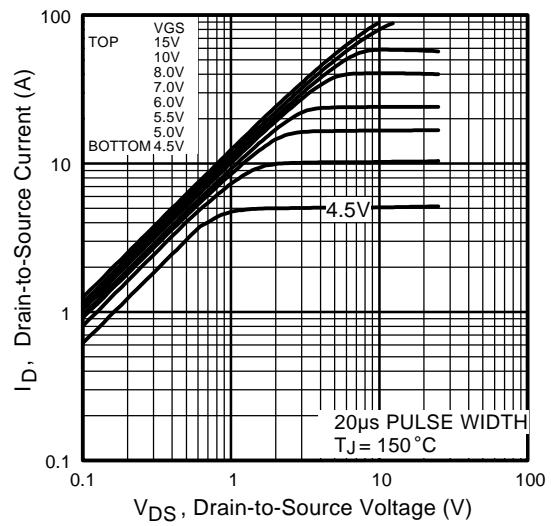


Fig 2. Typical Output Characteristics

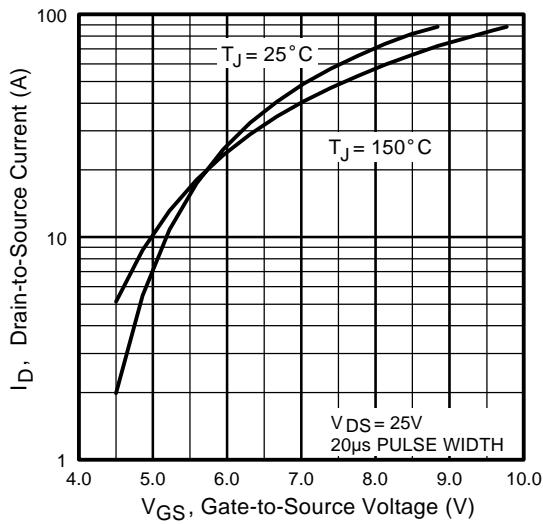


Fig 3. Typical Transfer Characteristics

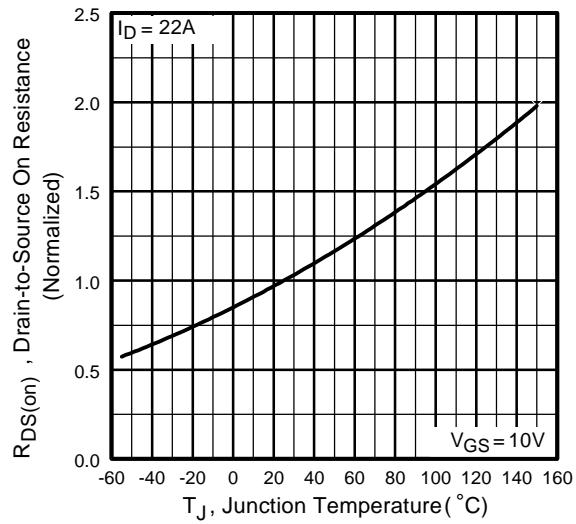


Fig 4. Normalized On-Resistance
Vs. Temperature

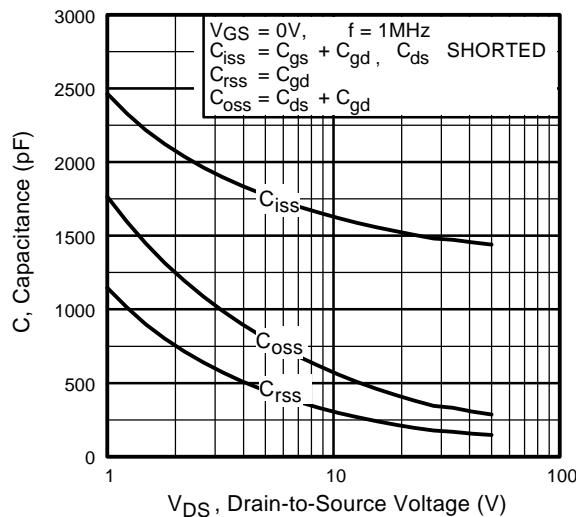


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

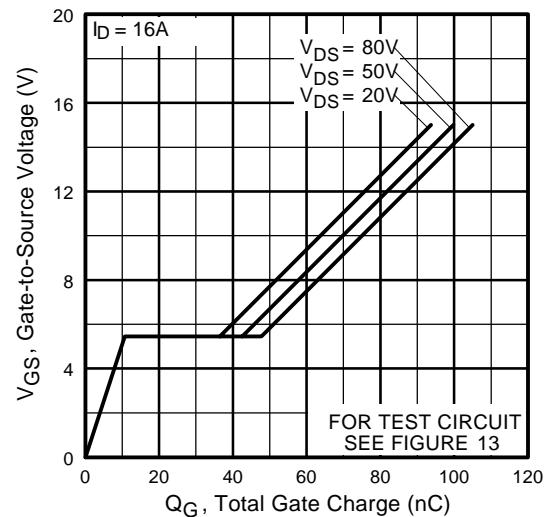


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

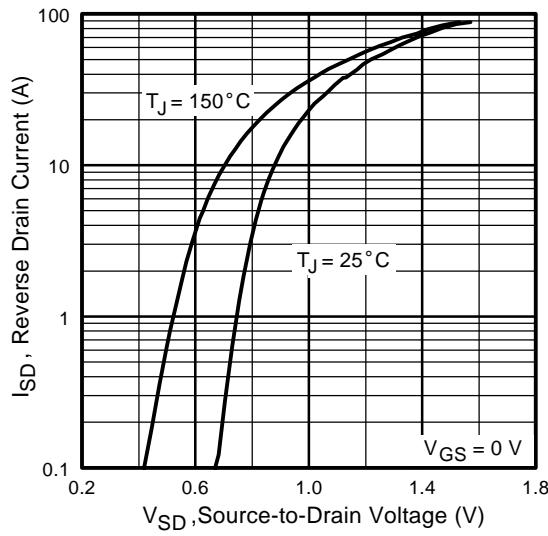


Fig 7. Typical Source-Drain Diode
Forward Voltage

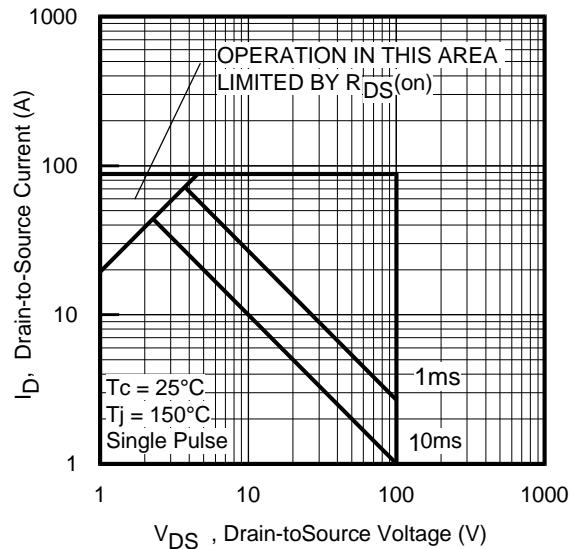


Fig 8. Maximum Safe Operating Area

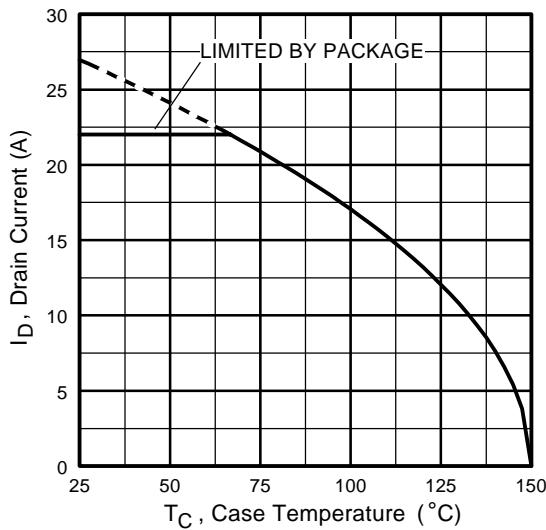


Fig 9. Maximum Drain Current Vs.
Case Temperature

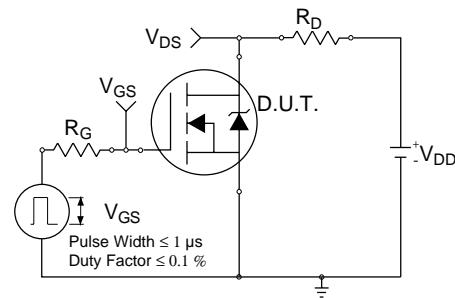


Fig 10a. Switching Time Test Circuit

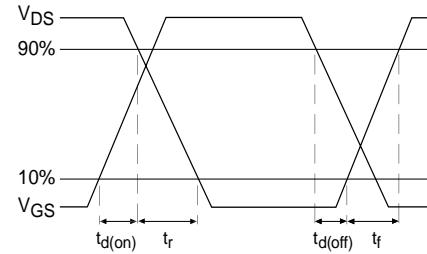


Fig 10b. Switching Time Waveforms

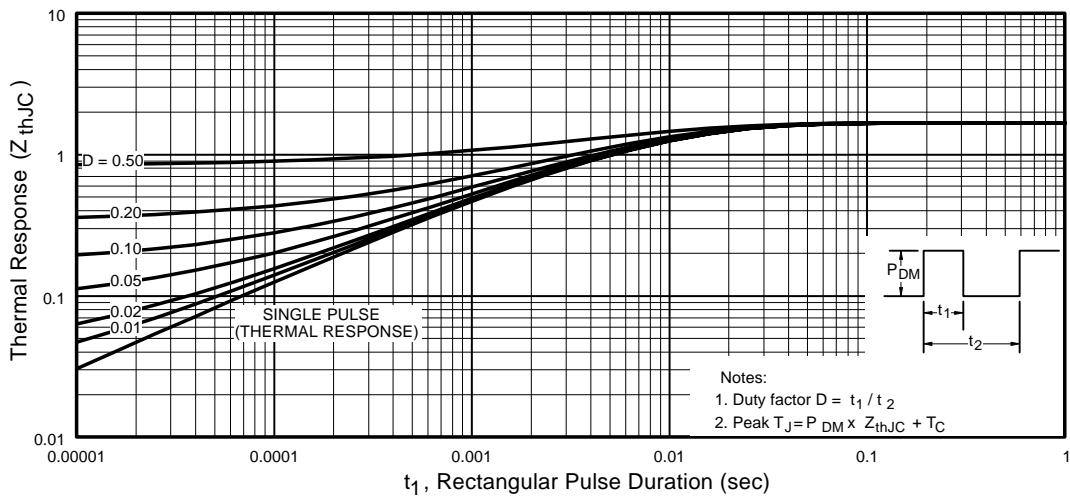
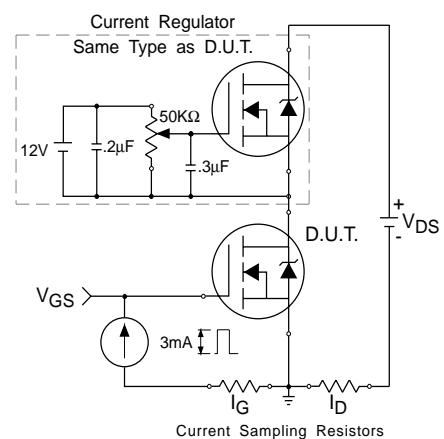
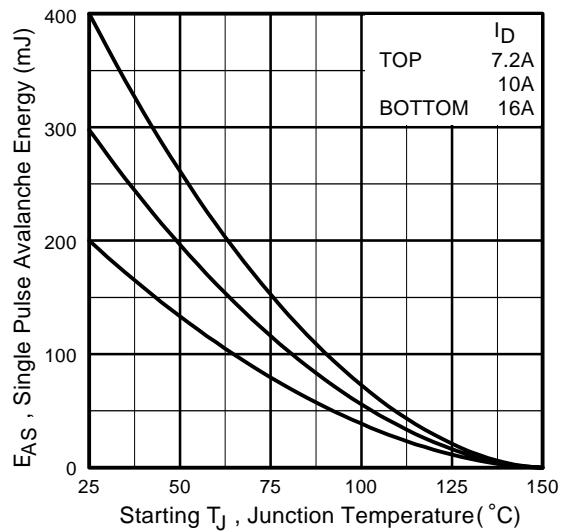
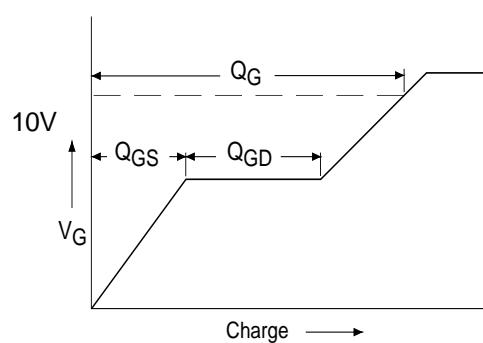
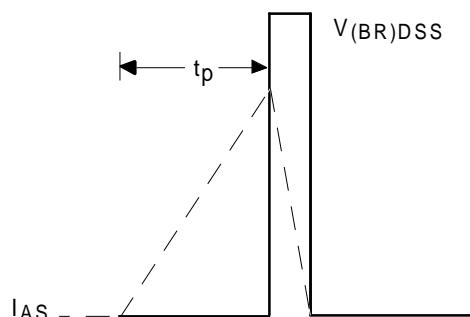
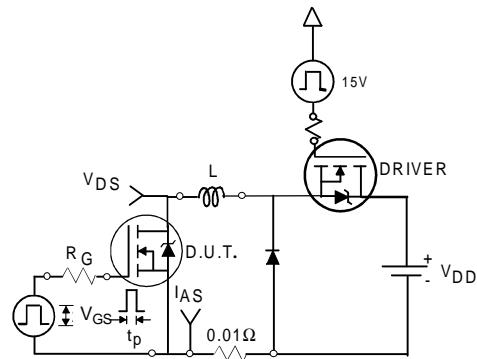


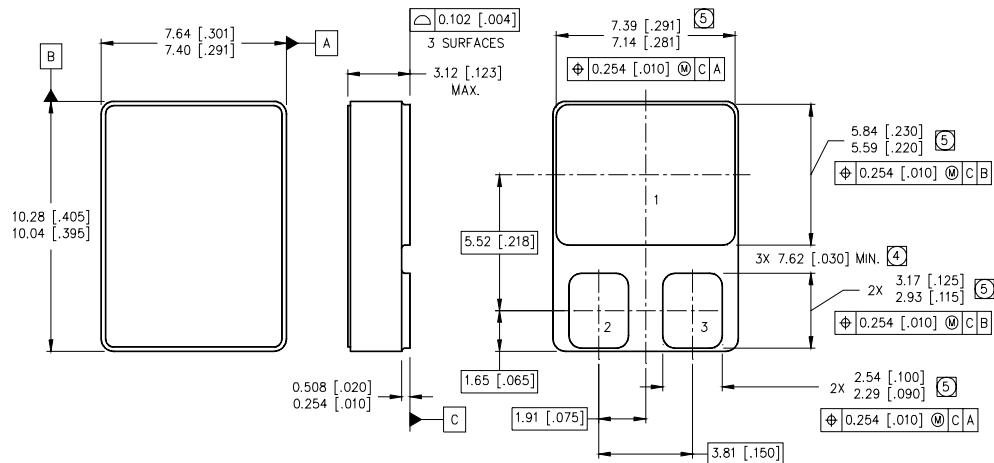
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V_{DD} = 25 V, Starting T_J = 25°C, L=1.5mH Peak I_{AS} =16A, V_{GS} = 10 V, R_G= 25Ω
- ③ I_{SD} ≤ 16A, di/dt ≤ 350 A/μs, V_{DD} ≤ 100V, T_J ≤ 150°C
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

Case Outline and Dimensions — SMD-0.5



NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- ④ DIMENSION INCLUDES METALLIZATION FLASH.
- ⑤ DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

PAD ASSIGNMENTS

- 1 = DRAIN
- 2 = GATE
- 3 = SOURCE

International
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IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

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Data and specifications subject to change without notice. 07/01